

Preliminary

SIDC42D120F6

Fast switching diode chip in EMCON-Technology

FEATURES:

- 1200V EMCON technology 120 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules and discrete devices



Applications:

• SMPS, resonant applications, drives

Chip Type	V_R	I _F	Die Size	Package	Ordering Code
SIDC42D120F6	1200V	50A	6.5 x 6.5 mm ²	sawn on foil	Q67050-A4185- A001

MECHANICAL PARAMETER:

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Raster size	6.5 x 6.5				
Area total / active	42.25 / 33.99	mm ²			
Anode pad size	5.78 x 5.78				
Thickness	120	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	334 pcs				
Passivation frontside	Photoimide				
Anode metallisation	3200 nm AlSiCu				
Cathode metallisation	1400 nm Ni Ag –system suitable for epoxy and soft solder die bor	ding			
Die bond electrically conductive glue or so					
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitroge < 6 month at an ambient temperature of 2				



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}		1200	V
Continuous forward current limited by T_{jmax}	I _F		50	
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \; ms \; sinusoidal$	tbd	А
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		100	
Operating junction and storage temperature	$T_{\rm j}$, $T_{ m stg}$		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
raiailietei	Symbol	Conditions		min.	Тур.	max.	
Reverse leakage current	I_{R}	V _R =1200V	<i>T_j</i> =25 °C			250	μΑ
Cathode-Anode breakdown Voltage	V _{Br}	I _R =4mA	<i>T_j</i> =25°C	1200			V
Forward voltage drop	V _F	I _F =50A	<i>T_j</i> =25°C		2.1		V

Dynamic Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions -		Value			Unit
- arameter	Syllibol			min.	Тур.	max.	
Reverse recovery time	t _{rr1}	I _F =50A	$T_j = 25$ °C		tbd		
	t _{rr2}	di/dt=A/ms $V_R=600V$	$T_j = 150 ^{\circ}\text{C}$				ns
Peak recovery current	I _{RRM1}	I _F =50A	$T_j = 25$ °C		tbd		Α
	I _{RRM2}	$di/dt = A/ms$ $V_R = 600V$	$T_j = 150$ °C				
Reverse recovery charge	Q _{rr1}	I _F =50A	T _j =25°C		tbd		nC
	Q _{rr2}	di/dt = A/ms $V_R = 600V$	T _j =150°C				
Peak rate of fall of reverse	di _{rr1} /dt	I _F =50A	T _j =25°C		tbd		A / -
recovery current	di _{rr2} /dt	di/dt=A/ms V _R = 600V	T _j =150°C				A/μs
Softness	S1	$I_F=50A$ di/dt=A/ms	T _j =25°C		tbd		1
	S2	$V_R = 600V$	T _j =150°C				<u> </u>

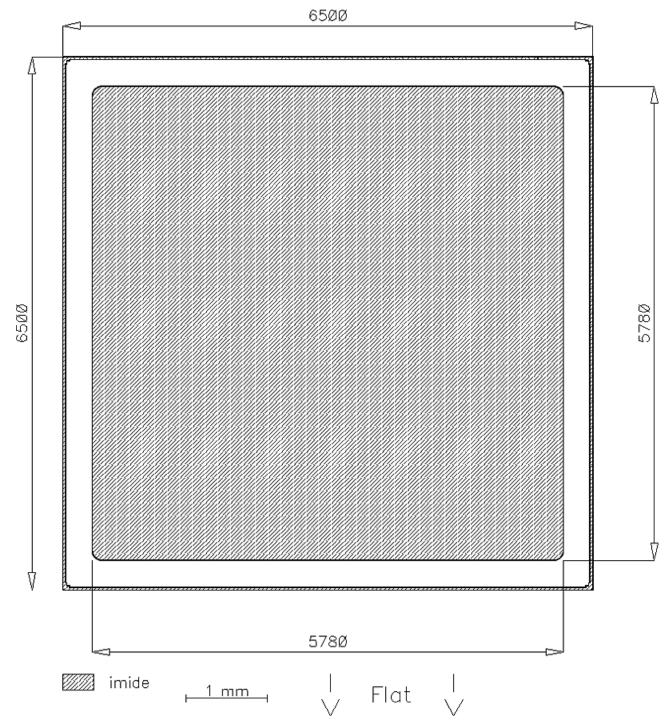


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CHIP DRAWING:

L419B1 mm2

Die-Size 6500 um x 6500 um



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FURTHER ELECTRICAL CHARACTERISTICS:

de de dete ele et	tbd	
device data sheet	TUPEC LDG	

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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